LIST OF	ART CITED	BY API	PLICANT	ATTY. DOCKET NO. YHK-0121		APPLN. SERIAL NO. 10/675,987	
(PTO-1449) OTP E 108 1004 12				APPLICANT(S) Eung Chul PARK			
				FILING DATE GROUP October 2, 2003		· · · · · · · · · · · · · · ·	
U.S. PATEN	T.DOCUMENTS:		9.1		14. 新游客、 2. 9s 12. 13. 新色出版		<u></u>
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